## **1** Better Distortion with Distribution

There is a well known lowerbound for the distortion of embedding a finite metric (*X*, *d*) into  $\ell_1$ .

**Theorem 1.1** For any finite metric (*X*, *d*) on *n* points, one has

$$(X,d) \xrightarrow{\Omega(\log n)} \ell_1.$$

For  $\ell_2$  the lowerbound is still  $\Omega(\log n)^{-1}$ .

Recall that we want to find a  $(O(k), (1 + \varepsilon)c)$ -outlier embedding into  $\ell_2$  for any finite metric (X, d) which admits a (k, c)-outlier embedding into  $\ell_2$ . If we can do this deterministically, we actually find an embedding of the outlier points into  $\ell_2$  with distortion O(k), which contradicts the lowerbound. However, maybe we can do O(k) via embedding into some distribution of  $\ell_2$  metrics.

Let (X, d) be a finite metric and let  $\mathcal{Y} = \{(Y_1, d_1), \dots, (Y_h, d_h)\}$  be a set of metrics where |X| = |Y| = n. Let  $\pi$  be a distribution on  $\mathcal{Y}$ . The original metric (X, d) embeds into  $\pi$  with distortion D if there is an r > 0 such that for all  $x, y \in X$ ,

$$r \le \frac{\mathrm{E}[d_i(x,y)]}{d(x,y)} \le Dr.$$

SODA23 paper also embeds (X, d) into distribution.

## 1.1 Example: Random Trees

Consider the problem of embedding some finite metric into a tree metric. We can get an O(n) lowerbound via the unit edge length cycle  $C_n$ . However, if embedding into distortions is allowed, we can do  $O(\log n)$ .

**Theorem 1.2 (Bartal)** Let (X, d) be a metric on n points with diameter  $\Delta$ , let  $\mathcal{D}T$  be the set of tree metrics that dominate d, there is a distribution  $\pi$  on  $\mathcal{D}T$  such that (X, d) embeds into pi with distortion  $O(\log n \log \Delta)$ .

<sup>&</sup>lt;sup>1</sup>https://web.stanford.edu/class/cs369m/cs369mlecture1.pdf